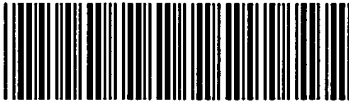


Search Notes

Application/Control No.

10/707,087

Examiner

Brian S. Kwon

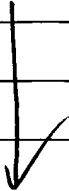
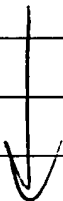
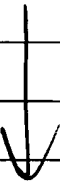
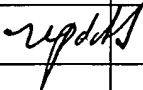
Applicant(s)/Patent under
Reexamination

MAJEED ET AL.

Art Unit

1614

SEARCHED

Class	Subclass	Date	Examiner
514	460	6/26/2006	BK
	453		
	455		
	909		
			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated (str,east,npl)	9/26/2006	BK
updated (continuity data, inventor name search)		